

MOSFET

600V CoolMOS™ SJ S7 Power Device

IPDQ60R017S7 enables the best price performance for low frequency switching applications. CoolMOS $^{\text{TM}}$ S7 boasts the lowest R_{DS(on)} values for a HV SJ MOSFET, with distinctive increase of energy efficiency.

CoolMOS™ S7 is optimized for "static switching" and high current applications. It is an ideal fit for solid state relay and circuit breaker designs as well as for line rectification in SMPS and inverter topologies.

Features

- CoolMOS $^{\text{TM}}$ S7 technology enables 17m Ω R_{DS(on)} in the smallest footprint
- Optimized price performance in low frequency switching applications
- · High pulse current capability
- Kelvin Source pin improves switching performance at high current
- QDPAK (PG-HDSOP-22-1) offers top side cooling with improved package thermals

Benefits

- Minimized conduction losses (eliminate / reduce heat sink)
- Increased system performance
- More compact and easier design
- Lower BOM or/and TCO over prolonged life time

Compared to electromechanical devices:

- Faster switching times
- · Higher reliability and longer system life time
- Shock & vibration resistance
- No contact arcing, bouncing or degradation over life time

Potential applications

- · Solid state relays and circuit breakers
- Line rectification in high power/performance applications e.g. Computing, Telecom, UPS and Solar

Product validation

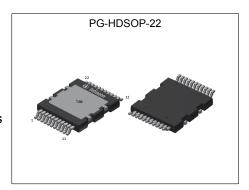
Fully qualified according to JEDEC for Industrial Applications

Please note: The source and sense source pins are not exchangeable. Their exchange might lead to malfunction. For paralleling 4pin MOSFET devices the placement of the gate resistor is generally recommended to be on the Driver Source instead of the Gate.

Table 1 Key Performance Parameters

Parameter	Value	Unit
R _{DS(on),max}	17	mΩ
$Q_{g,typ}$	196	nC
V _{SD}	0.82	V
Pulsed I _{SD} , I _{DS}	491	A

Type / Ordering Code	Package	Marking	Related Links
IPDQ60R017S7	PG-HDSOP-22	60R017S7	see Appendix A



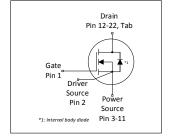










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600V CoolMOS™ SJ S7 Power Device

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1 Maximum ratings at $T_j = 25$ °C, unless otherwise specified

Table 2 Maximum ratings

Davamatav	Values					Note / Took Condition	
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Drain current rating	ID	-	-	30	A	T _C =140°C Current is limited by T _{j max} = 150°C; Lower case temp does increase current capability	
Pulsed drain current ¹⁾	I _{D,pulse}	-	-	491	Α	T _C =25°C	
Avalanche energy, single pulse	E _{AS}	-	-	378	mJ	I _D =4.5A; V _{DD} =50V; see table 10	
Avalanche current, single pulse	I _{AS}	-	-	4.5	Α	-	
MOSFET dv/dt ruggedness ²⁾	dv/dt	-	-	20	V/ns	V _{DS} = 0V to 300V	
Gate source voltage (static)	V _{GS}	-20	-	20	V	static	
Gate source voltage (dynamic)	V _{GS}	-30	-	30	V	AC (f>1 Hz)	
Power dissipation	P _{tot}	-	-	500	W	T _C =25°C	
Storage temperature	T _{stg}	-55	-	150	°C	-	
Operating junction temperature	T _j	-55	-	150	°C	-	
Mounting torque	-	-	-	n.a.	Ncm	-	
Diode forward current rating	Is	-	-	30	A	T _C =140°C Current is limited by T _{j max} = 150°C; Lower case temp does increase current capability	
Diode pulse current ¹⁾	I _{S,pulse}	-	-	491	Α	T _C =25°C	
Reverse diode dv/dt ³⁾	dv/dt	-	-	5	V/ns	$V_{\rm DS}$ =0 to 300V, $I_{\rm SD}$ <=29A, $T_{\rm j}$ =25°C see table 8	
Maximum diode commutation speed	di _f /dt	-	-	1000	A/μs	V_{DS} =0 to 300V, I_{SD} <=29A, T_{j} =25°C see table 8	
Insulation withstand voltage	V _{ISO}	-	-	n.a.	V	$V_{\rm rms}$, $T_{\rm C}$ =25°C, t =1min	

 $^{^{1)}}$ Pulse width t_p limited by $T_{j,\text{max}}$ $^{2)}$ The dv/dt has to be limited by appropriate gate resistor $^{3)}$ Identical low side and high side switch

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2 Thermal characteristics

 Table 3
 Thermal characteristics

Davamatav	Cumbal	Values			11	Note / Took Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Thermal resistance, junction - case	R _{thJC}	-	-	0.25	°C/W	-
Thermal resistance, junction - ambient	R _{thJA}	-	-	62	°C/W	device on PCB, minimal footprint
Thermal resistance, junction - ambient for SMD version	/ NthJA	-	45	55	°C/W	Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70µm thickness) copper area. Tap exposed to air. PCB is vertical without air stream cooling.
Soldering temperature, reflow soldering allowed	T _{sold}	-	_	260	°C	reflow MSL1

infineon

3 Electrical characteristics

at T_i =25°C, unless otherwise specified

Table 4 Static characteristics

For applications with applied blocking voltage >70% of the specified blocking voltage, it is required that the customer evaluates the impact of cosmic radiation effect in early design phase and contacts the Infineon sales office for the necessary technical support by Infineon

Bananatan	Cyronhad		Values			Nata (Tast Oan dition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Drain-source breakdown voltage	V _{(BR)DSS}	600	-	-	V	V _{GS} =0V, I _D =1mA
Gate threshold voltage	$V_{(GS)th}$	3.5	4.0	4.5	V	$V_{\rm DS}=V_{\rm GS},\ I_{\rm D}=1.89{\rm mA}$
Zero gate voltage drain current	$I_{ m DSS}$	-	- 60	6	μΑ	V _{DS} =600V, V _{GS} =0V, T _j =25°C V _{DS} =600V, V _{GS} =0V, T _j =150°C
Gate-source leakage current	I _{GSS}	-	-	100	nA	V _{GS} =20V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	0.015 0.036	0.017	Ω	V _{GS} =12V, I _D =29A, T _i =25°C V _{GS} =12V, I _D =29A, T _i =150°C
Gate resistance R _G		-	0.9	-	Ω	f=1MHz, open drain

Table 5 Dynamic characteristics

Danamatan	Ob. a.l		Values				
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition	
Input capacitance	C _{iss}	-	7370	-	pF	V _{GS} =0V, V _{DS} =300V, f=250kHz	
Output capacitance	Coss	-	116	-	pF	V _{GS} =0V, V _{DS} =300V, f=250kHz	
Effective output capacitance, energy related ¹⁾	C _{o(er)}	-	395	-	pF	V _{GS} =0V, V _{DS} =0 to 300V	
Effective output capacitance, time related ²⁾	C _{o(tr)}	-	3505	-	pF	I_D =constant, V_{GS} =0V, V_{DS} =0 to 300V	
Output charge	Qoss	-	1051	-	nC	V _{GS} =0V, V _{DS} =0 to 300V	
Turn-on delay time	$t_{\sf d(on)}$	-	35	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =29A, $R_{\rm G}$ =4.5 Ω ; see table 9	
Rise time	t _r	-	7	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =29A, $R_{\rm G}$ =4.5 Ω ; see table 9	
Turn-off delay time	$t_{ m d(off)}$	-	160	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =29A, $R_{\rm G}$ =4.5 Ω ; see table 9	
Fall time	t _f	-	9	-	ns	$V_{\rm DD}$ =300V, $V_{\rm GS}$ =13V, $I_{\rm D}$ =29A, $R_{\rm G}$ =4.5 Ω ; see table 9	

Table 6 Gate charge characteristics

Parameter	Cumbal	Values			11:4	Note / Test Condition
	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Gate to source charge	Q _{gs}	-	40	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =29A, $V_{\rm GS}$ =0 to 12V
Gate to drain charge	Q _{gd}	-	65	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =29A, $V_{\rm GS}$ =0 to 12V
Gate charge total	Qg	-	196	-	nC	$V_{\rm DD}$ =300V, $I_{\rm D}$ =29A, $V_{\rm GS}$ =0 to 12V
Gate plateau voltage	V _{plateau}	-	5.4	-	V	V_{DD} =300V, I_{D} =29A, V_{GS} =0 to 12V

 $^{^{1)}}$ $C_{\text{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 300V $^{2)}$ $C_{\text{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 300V

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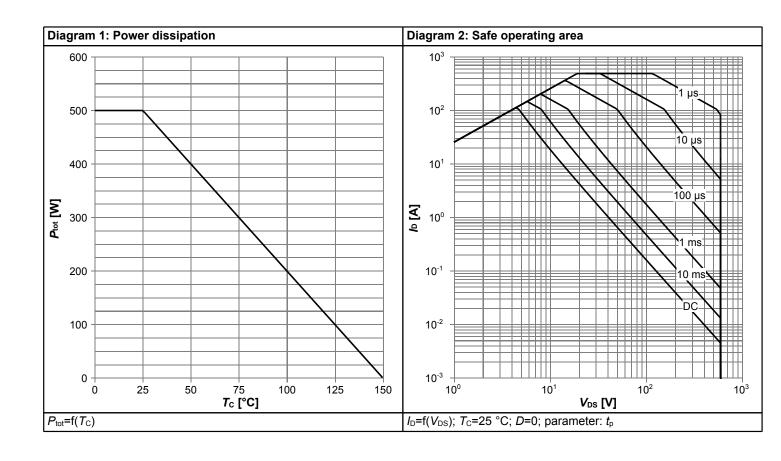


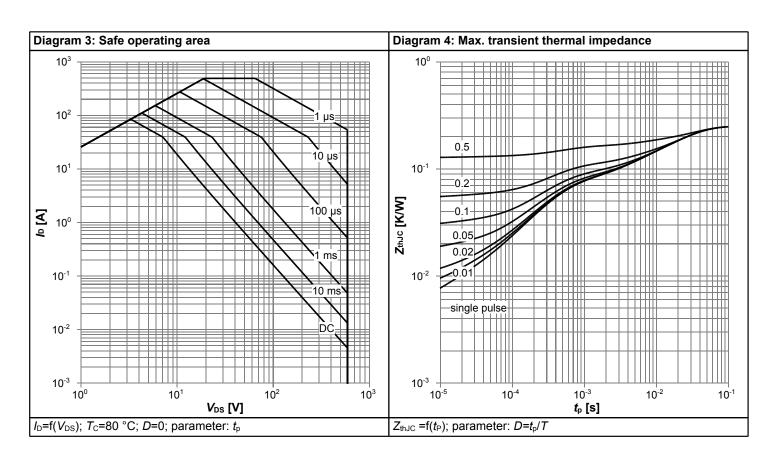
Table 7 Reverse diode characteristics

Davamatav	Cumbal	Values			11:4	Note / Test Condition
Parameter	Symbol	Min.	Тур.	Max.	Unit	Note / Test Condition
Diode forward voltage	V _{SD}	-	0.82	-	V	V _{GS} =0V, I _F =29A, T _j =25°C
Reverse recovery time	t _{rr}	-	510	-	ns	V_R =300V, I_F =29A, di_F/dt =100A/ μ s; see table 8
Reverse recovery charge	Qrr	-	11.5	-	μC	V_R =300V, I_F =29A, di_F/dt =100A/ μ s; see table 8
Peak reverse recovery current	I _{rrm}	-	45	-	А	V_R =300V, I_F =29A, di_F/dt =100A/ μ s; see table 8

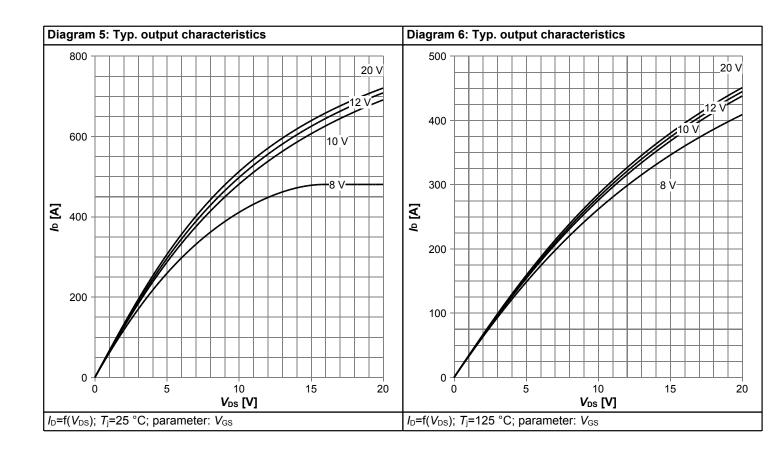


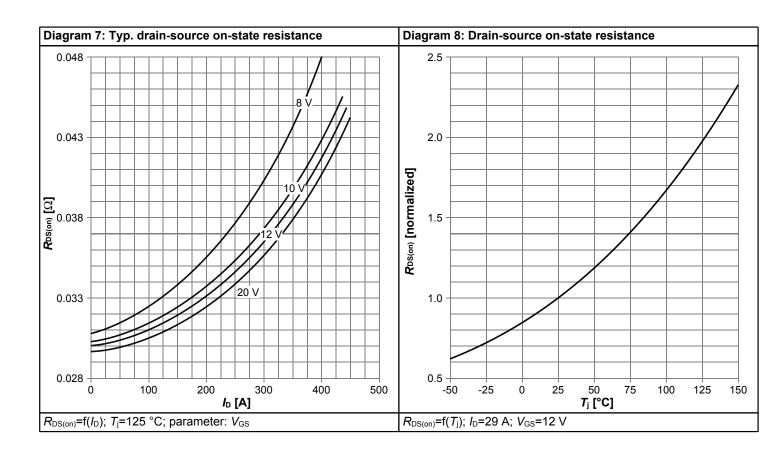
4 Electrical characteristics diagrams



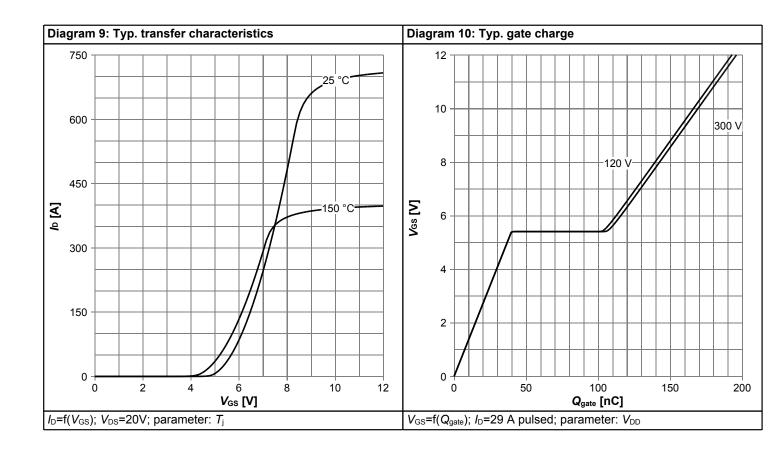


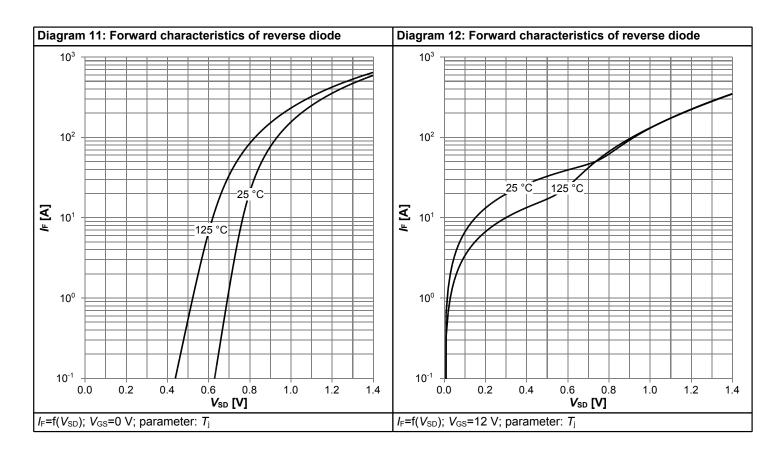




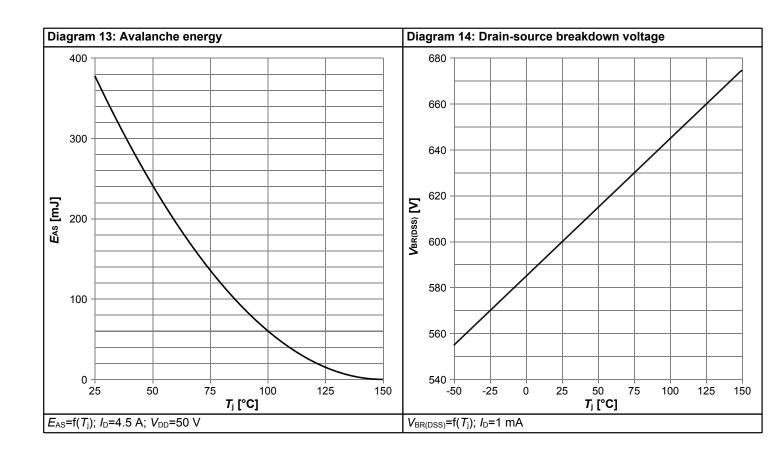


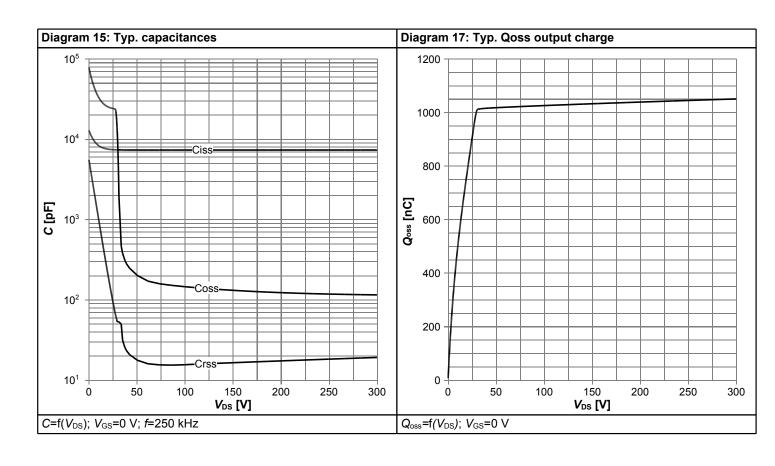














5 Test Circuits

Table 8 Diode characteristics

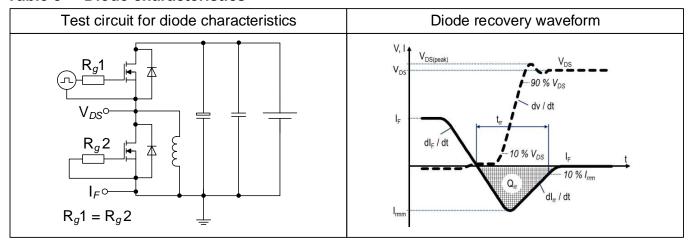


Table 9 Switching times (ss)

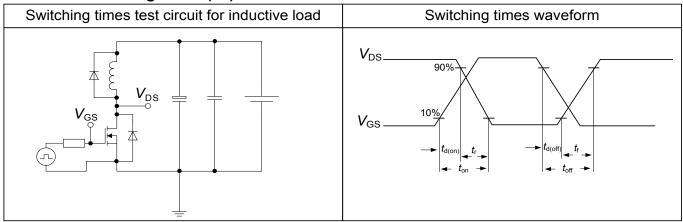
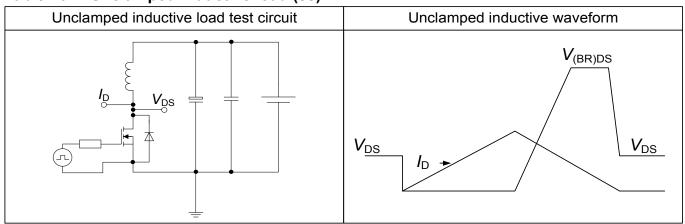
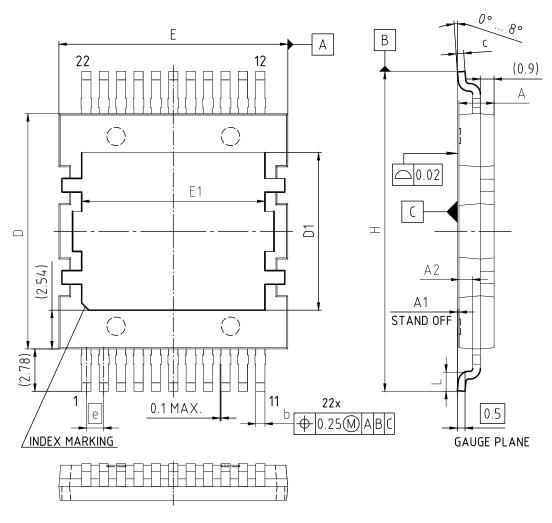


Table 10 Unclamped inductive load (ss)





6 Package Outlines



NOTES:

- 1. ALL DIMENSIONS REFER TO JEDEC STANDARD TO-252 AND DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.
- 2. ALL METAL SUFACES ARE TIN PLATED, EXCEPT AREA OF CUT.

DIMENSIONS	MILLIMETERS					
DIMIENSIONS	MIN.	MAX.				
Α	2.20	2.35				
A1	0.00	0.15				
A2	0.89	1.10				
b	0.50	0.70				
С	0.46	0.58				
D	15.30	15.50				
D1	10.23	10.43				
E	14.90	15.10				
E1	11.91	12.11				
е	1.14					
N	22					
Н	20.86	21.06				
L	1.20	1.40				

DOCUMENT NO. Z8B00184650					
REVISION 02					
SCALE 5:1					
0 1 2 3 4 5mm					
EUROPEAN PROJECTION					
ISSUE DATE 16.01.2018					

Figure 1 Outline PG-HDSOP-22, dimensions in mm



7 Appendix A

Table 11 Related Links

• IFX CoolMOS S7 Webpage: www.infineon.com

• IFX CoolMOS S7 application note: www.infineon.com

• IFX CoolMOS S7 simulation model: www.infineon.com

• IFX Design tools: www.infineon.com



Revision History

IPDQ60R017S7

Revision: 2022-11-23, Rev. 2.0

Previous Revision

Revision	Date	Subjects (major changes since last revision)				
2.0	2022-11-23	Release of final version				

Trademarks

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Final Data Sheet 14 Rev. 2.0, 2022-11-23